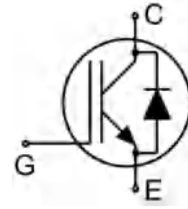
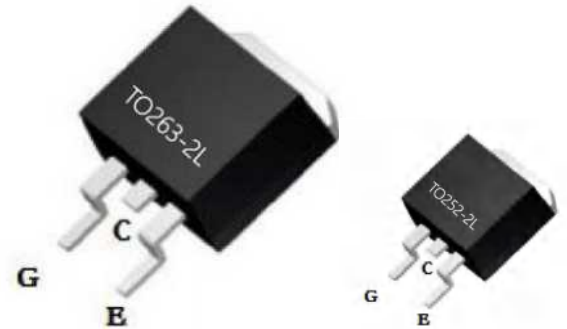


Trench Field-Stop Technology IGBT
YZPST-6H60CX1G3
Features

- 600V, 6A
- $V_{CE(sat)(typ.)} = 1.75V @ V_{GE} = 15V, I_C = 6A$
- Low Q_g
- Maximum Junction Temperature 175°C
- Pb-free Lead Plating; RoHS Compliant


Applications

- Solar Converters
- Uninterrupted Power Supply
- Welding Converters
- Mid to High Range Switching Frequency Converters


Key Performance and Package Parameters

Order codes	V_{CE}	I_C	$V_{CEsat}, T_{vj}=25^{\circ}C$	T_{vjmax}	Marking	Package
60H060CX1R3	650V	6A	1.75V	175°C	6H60CX1R3	TO263-2L
60H060CX1G3	650V	6A	1.75V	175°C	6H60CX1G3	TO252-2L

Absolute Maximum Ratings

Symbol	Parameter	Value	Unit
V_{CES}	Collector-Emitter Voltage	600	V
V_{GES}	Gate-Emitter Voltage	±20	V
I_C	Continuous Collector Current ($T_C=25^{\circ}C$)	12	A
	Continuous Collector Current ($T_C=100^{\circ}C$)	6	A
I_{CM}	Pulsed Collector Current (Note 1)	18	A
P_D	Maximum Power Dissipation ($T_C=25^{\circ}C$)	89	W
	Maximum Power Dissipation ($T_C=100^{\circ}C$)	44	W
T_J	Operating Junction Temperature Range	-40 to 175	°C
T_{STG}	Storage Temperature Range	-55 to 150	°C

Thermal Data

Symbol	Parameter	Conditioins	Max.	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case for IGBT		1.68	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction to Case for Diode		2.6	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	TO263-2L	62	°C/W
		TO252-2L	80	°C/W

Electrical Characteristics ($T_c=25^\circ\text{C}$ unless otherwise noted.)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit	
BV_{CES}	Collector-Emitter Breakdown Voltage	$V_{GE}=0V, I_c=200\mu A$	600	---	---	V	
I_{CES}	Collector-Emitter Leakage Current	$V_{CE}=600V, V_{GE}=0V$	---	---	40	μA	
I_{GES}	Gate Leakage Current, Forward	$V_{GE}=20V, V_{CE}=0V$	---	---	100	nA	
	Gate Leakage Current, Reverse	$V_{GE}=-20V, V_{CE}=0V$	---	---	100	nA	
$V_{GE(th)}$	Gate Threshold Voltage	$V_{GE}=V_{CE}, I_c=200\mu A$	3.2	3.9	4.8	V	
$V_{CE(sat)}$	Collector-Emitter Saturation Voltage	$V_{GE}=15V, I_c=6A, T_j=25^\circ\text{C}$	---	1.75	2.10	V	
		$V_{GE}=15V, I_c=6A, T_j=150^\circ\text{C}$	---	2.05	---	V	
Q_G	Total Gate Charge	$V_{CC}=400V$	---	11.5	---	nC	
Q_{GE}	Gate-Emitter Charge	$V_{GE}=15V$	---	3.5	---	nC	
Q_{GC}	Gate-Collector Charge	$I_c=6A$	---	3.5	---	nC	
$t_{d(on)}$	Turn-on Delay Time	$V_{CC}=400V$ $V_{GE}=\pm 15V$ $I_c=6A$ $R_G=10\Omega$ Inductive Load $T_C=25^\circ\text{C}$	---	12	---	ns	
t_r	Turn-on Rise Time		---	6	---	ns	
$t_{d(off)}$	Turn-off Delay Time		---	14	---	ns	
t_f	Turn-off Fall Time		---	154	---	ns	
E_{on}	Turn-on Switching Loss		---	91	---	μJ	
E_{off}	Turn-off Switching Loss		---	95	---	μJ	
E_{ts}	Total Switching Loss		---	186	---	μJ	
$t_{d(on)}$	Turn-on Delay Time		$V_{CC}=400V$ $V_{GE}=\pm 15V$ $I_c=6A$ $R_G=10\Omega$ Inductive Load $T_C=150^\circ\text{C}$	---	3	---	ns
t_r	Turn-on Rise Time			---	6	---	ns
$t_{d(off)}$	Turn-off Delay Time			---	18	---	ns
t_f	Turn-off Fall Time	---		214	---	ns	
E_{on}	Turn-on Switching Loss	---		48	---	μJ	
E_{off}	Turn-off Switching Loss	---		211	---	μJ	
E_{ts}	Total Switching Loss	---		259	---	μJ	
C_{ies}	Input Capacitance	$V_{CE}=25V$		---	313	---	pF
C_{oes}	Output Capacitance	$V_{GE}=0V$	---	34	---	pF	
C_{res}	Reverse Transfer Capacitance	$f=1\text{MHz}$	---	5	---	pF	
SCSOA	Short Circuit Safe Operation Area	$V_{GE}=15V, V_{CC}\leq 400V,$ $T_{J,start}\leq 25^\circ\text{C}$	9	---	---	μS	

Diode Characteristics ($T_C=25^{\circ}\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
V_F	Diode Forward Voltage	$I_F=6\text{A}$, $T_J=25^{\circ}\text{C}$	---	1.37	2.10	V
		$I_F=6\text{A}$, $T_J=150^{\circ}\text{C}$	---	1.20		V
t_{rr}	Diode Reverse Recovery Time	$V_R=400\text{V}$	---	46.5	---	ns
I_{rr}	Diode peak Reverse Recovery Current	$I_F=6\text{A}$ $di_F/dt=20\text{A}/\mu\text{s}$	---	0.35	---	A
Q_{rr}	Diode Reverse Recovery Charge	$T_C=25^{\circ}\text{C}$	---	8.5	---	nC
t_{rr}	Diode Reverse Recovery Time	$V_R=400\text{V}$	---	230	---	ns
I_{rr}	Diode peak Reverse Recovery Current	$I_F=6\text{A}$ $di_F/dt=20\text{A}/\mu\text{s}$	---	1	---	A
Q_{rr}	Diode Reverse Recovery Charge	$T_C=150^{\circ}\text{C}$	---	115	---	μC

Note1: Repetitive rating, pulse width limited by maximum junction temperature



Typical Characteristics

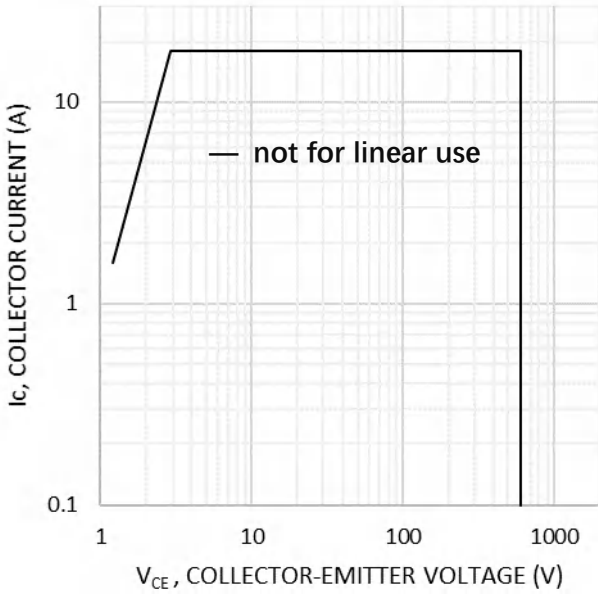


Fig. 1 Forward bias safe operating area (D=0, $T_c=25^\circ\text{C}$, $T_{vj}\leq 175^\circ\text{C}$; $V_{GE}=15\text{V}$)

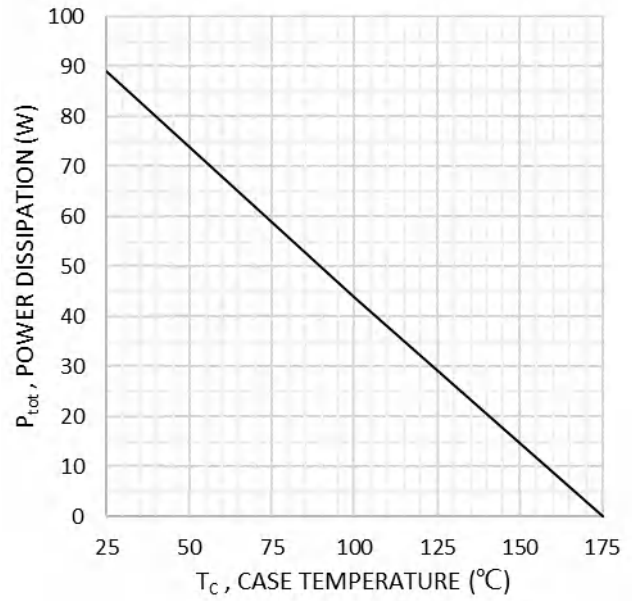


Fig. 2 Power dissipation as a function of case temperature ($T_{vj}\leq 175^\circ\text{C}$)

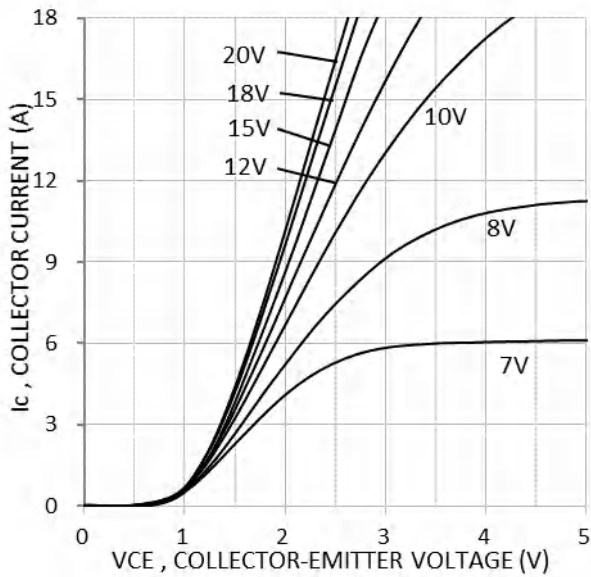


Fig. 3 Typical output characteristic ($T_{vj}=25^\circ\text{C}$)

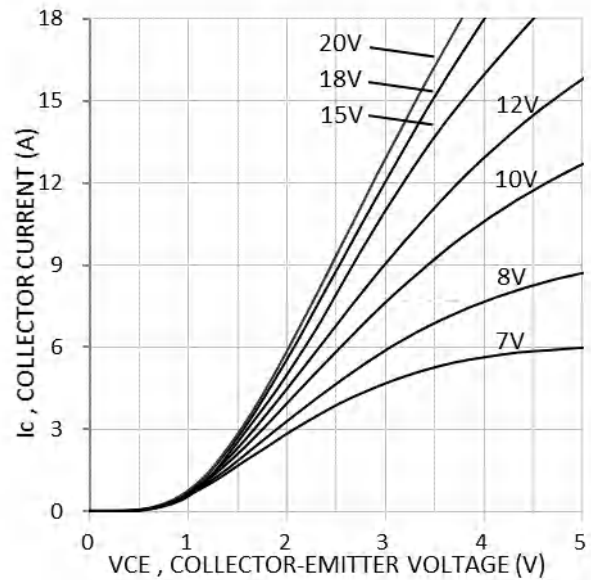


Fig. 4 Typical output characteristic ($T_{vj}=150^\circ\text{C}$)

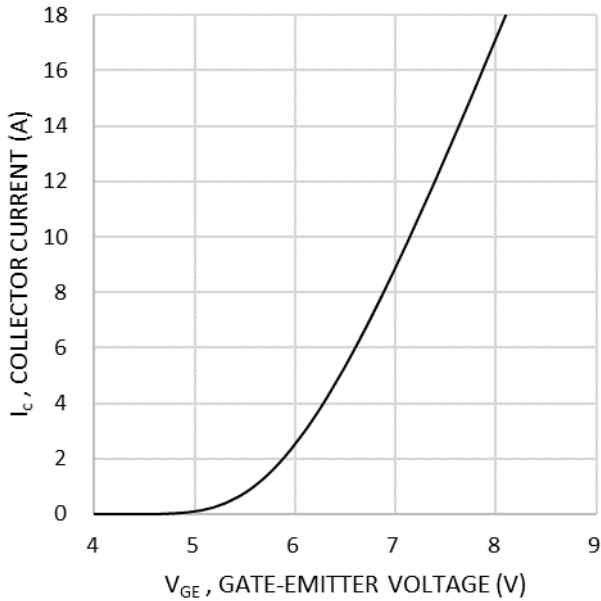


Fig. 5 Typical transfer characteristics ($V_{CE}=10V$)

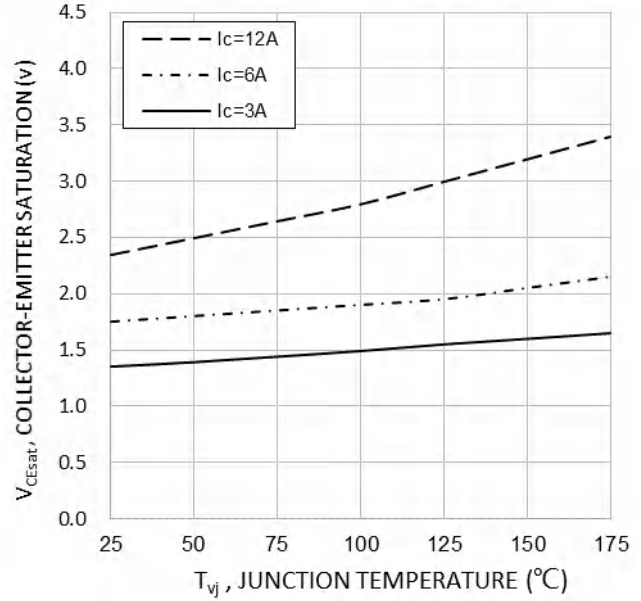


Fig. 6 Typical collector-emitter saturation voltage as a function of junction temperature ($V_{GE}=15V$)

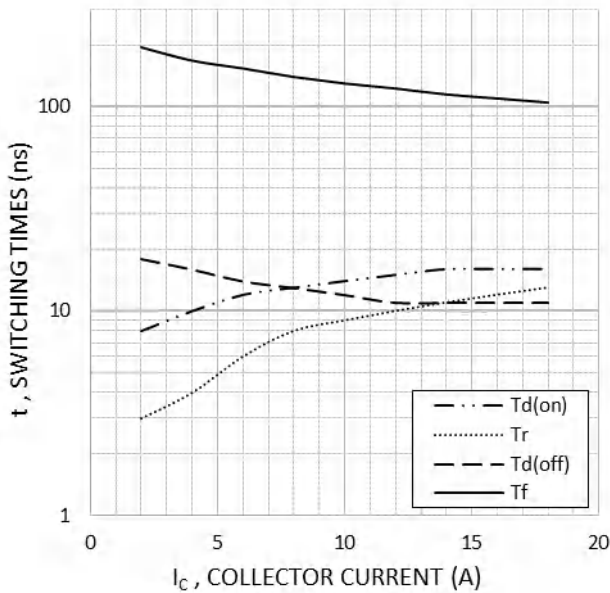


Fig. 7 Typical switching times as a function of collector current (inductive load, $T_{yj}=25^\circ C$, $V_{CE}=400V$, $V_{GE}=15/0V$, $r_G=10\Omega$)

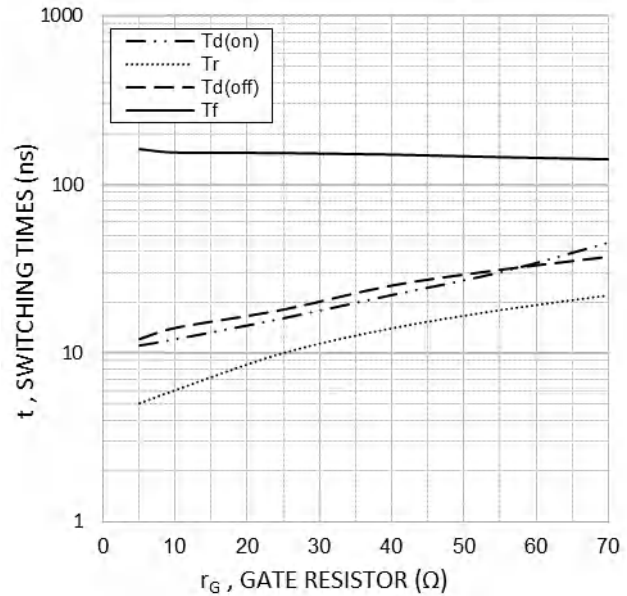


Fig. 8 Typical switching times as a function of gate resistor (inductive load, $T_{yj}=25^\circ C$, $V_{CE}=400V$, $V_{GE}=15/0V$, $I_C=6A$)

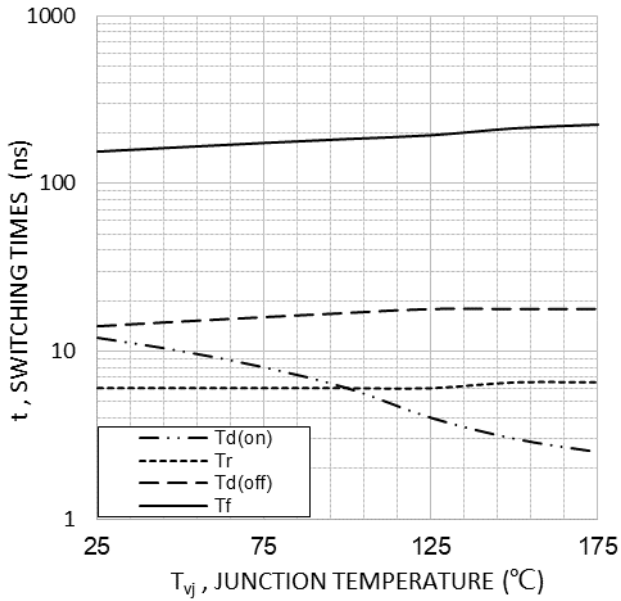


Fig. 9 Typical switching times as a function of junction temperature (inductive load, $V_{CE}=400V$, $V_{GE}=15/0V$, $I_C=6A$, $r_G=10\Omega$)

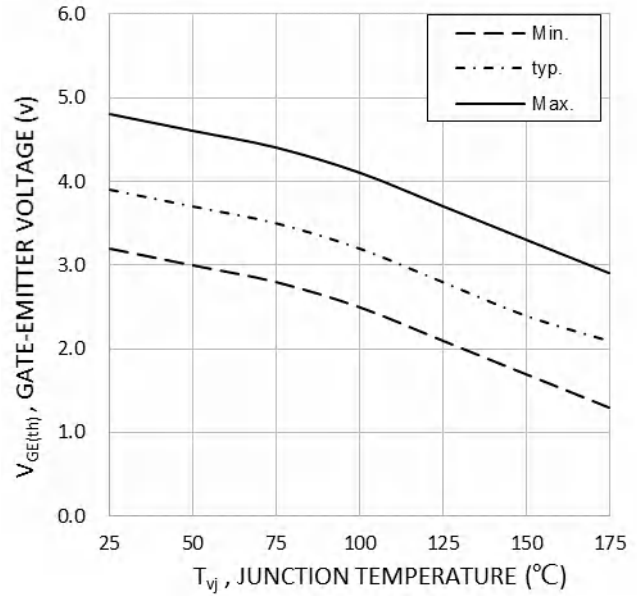


Fig. 10 Gate-emitter threshold voltage as a function of junction temperature ($I_C=0.2mA$)

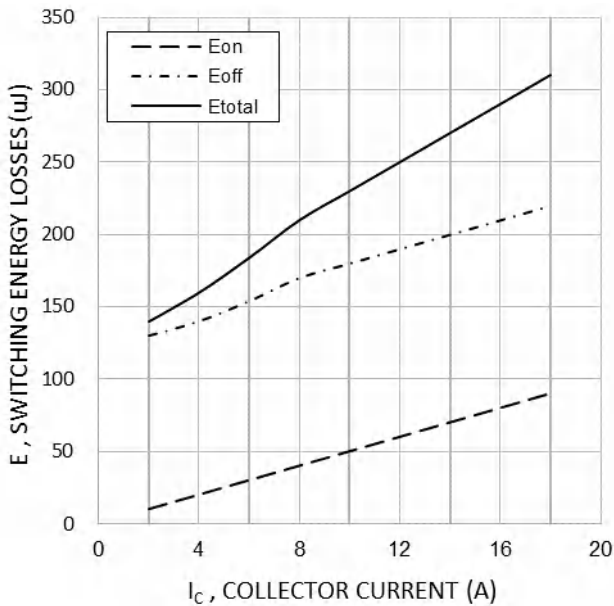


Fig. 11 Typical switching energy losses as a function of collector current (inductive load, $T_{vj}=25^\circ C$, $V_{CE}=400V$, $V_{GE}=15/0V$, $r_G=10\Omega$)

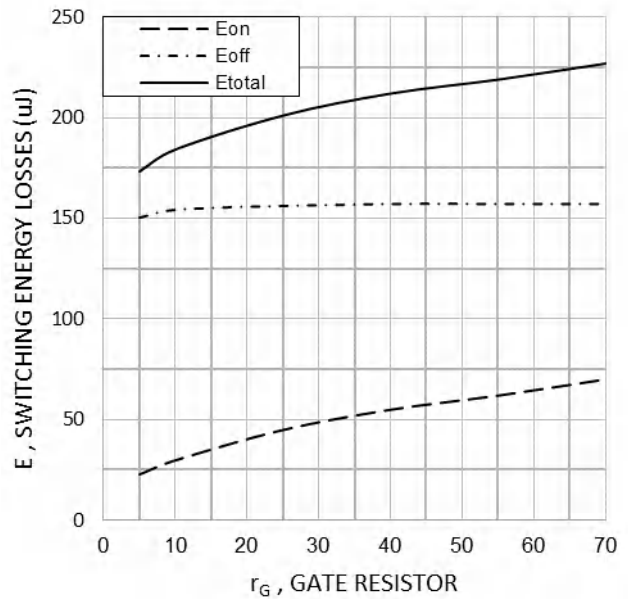


Fig. 12 Typical switching energy losses as a function of gate resistor (inductive load, $T_{vj}=25^\circ C$, $V_{CE}=400V$, $V_{GE}=15/0V$, $I_C=6A$)

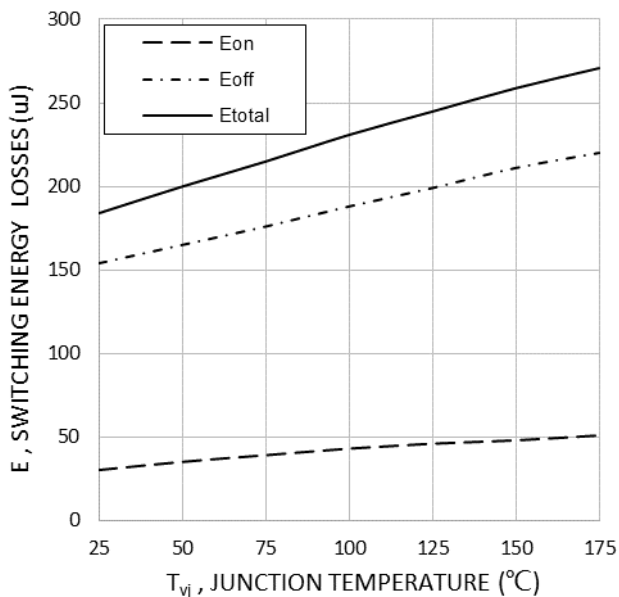


Fig. 13 Typical switching energy losses as a function of junction temperature (inductive load, $V_{CE}=600V$, $V_{GE}=15/0V$, $I_C=50A$, $r_G=10\Omega$)

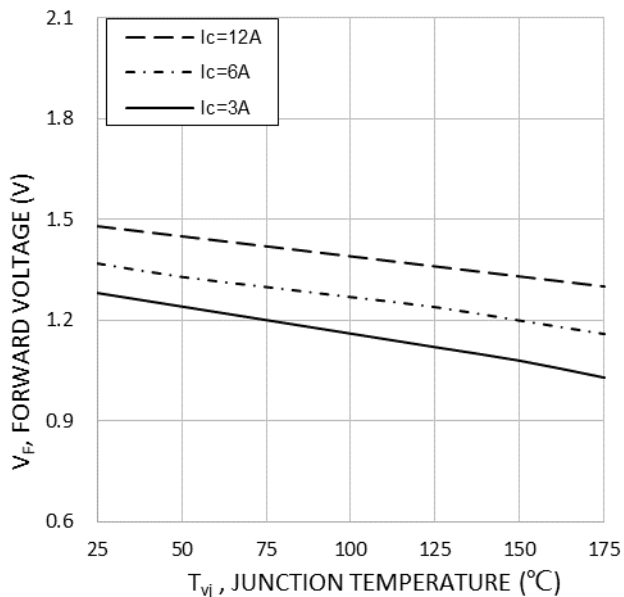


Fig. 14 Typical diode forward voltage as a function of junction temperature

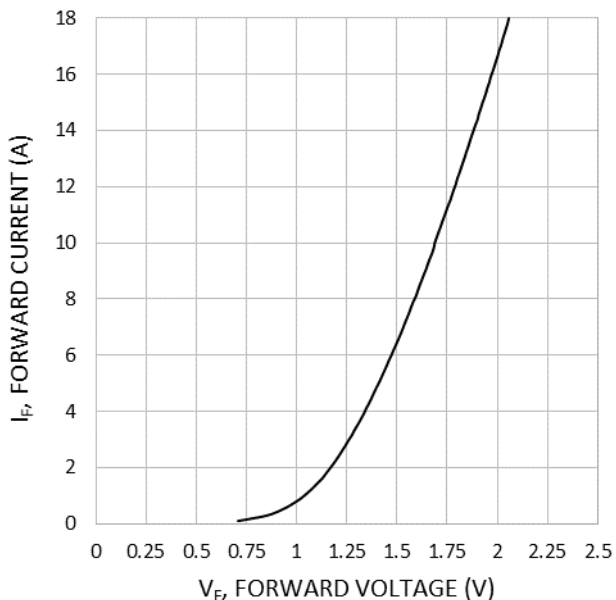


Fig. 15 Typical diode forward current as a function of forward voltage

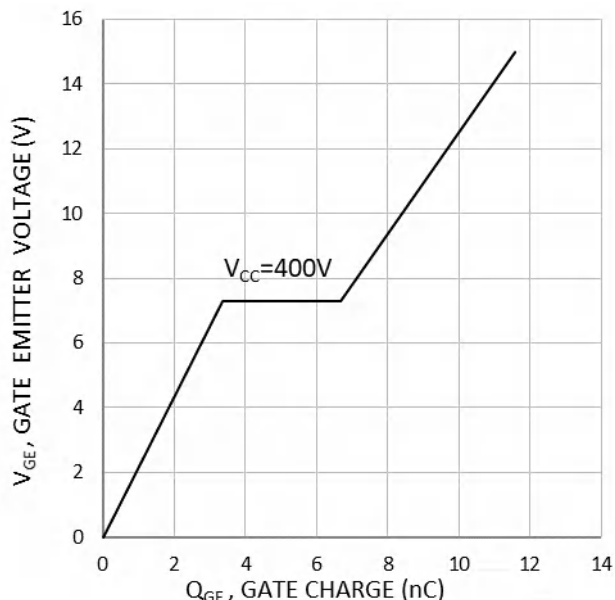


Fig. 16 Typical gate charge ($I_C=6A$)

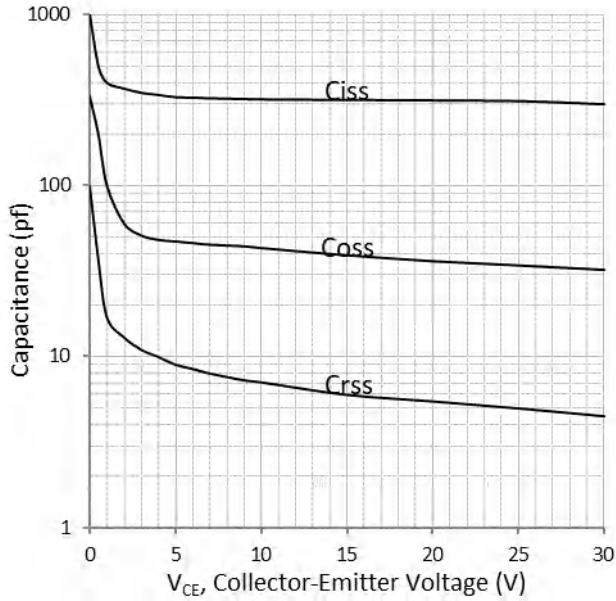


Fig. 17 Typical capacitance as a function of collector-emitter voltage ($V_{GE}=0V$, $f=1MHz$)

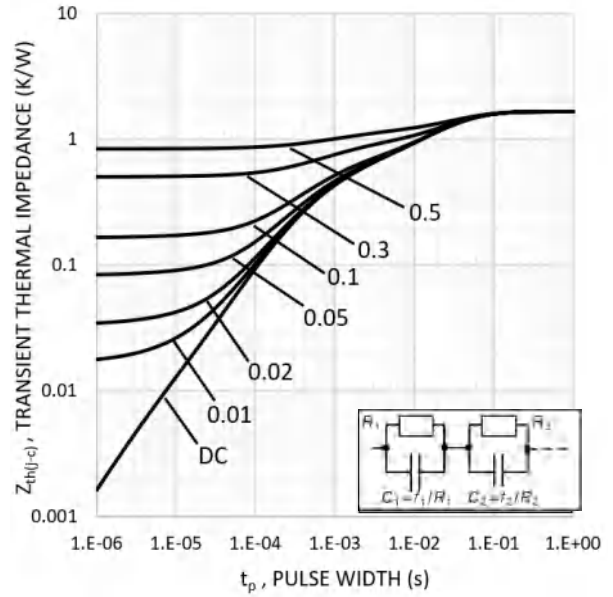


Fig. 18 IGBT transient thermal impedance ($D=t_p/T$)

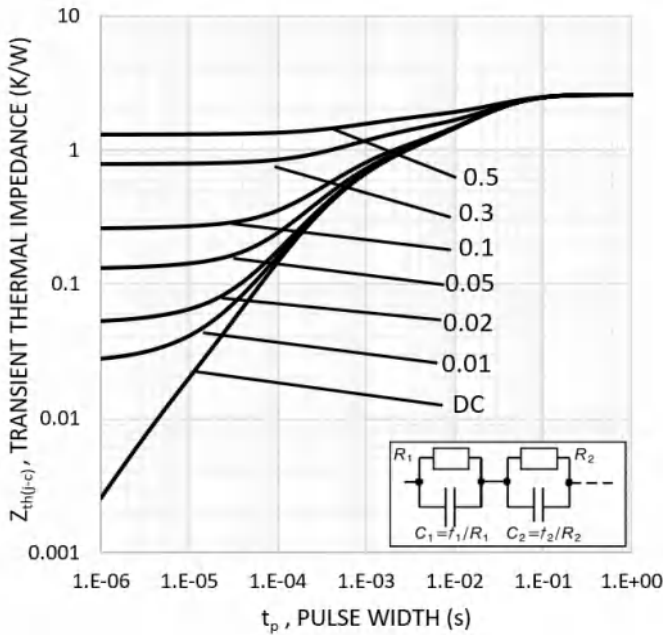
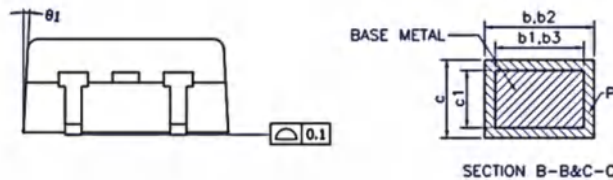
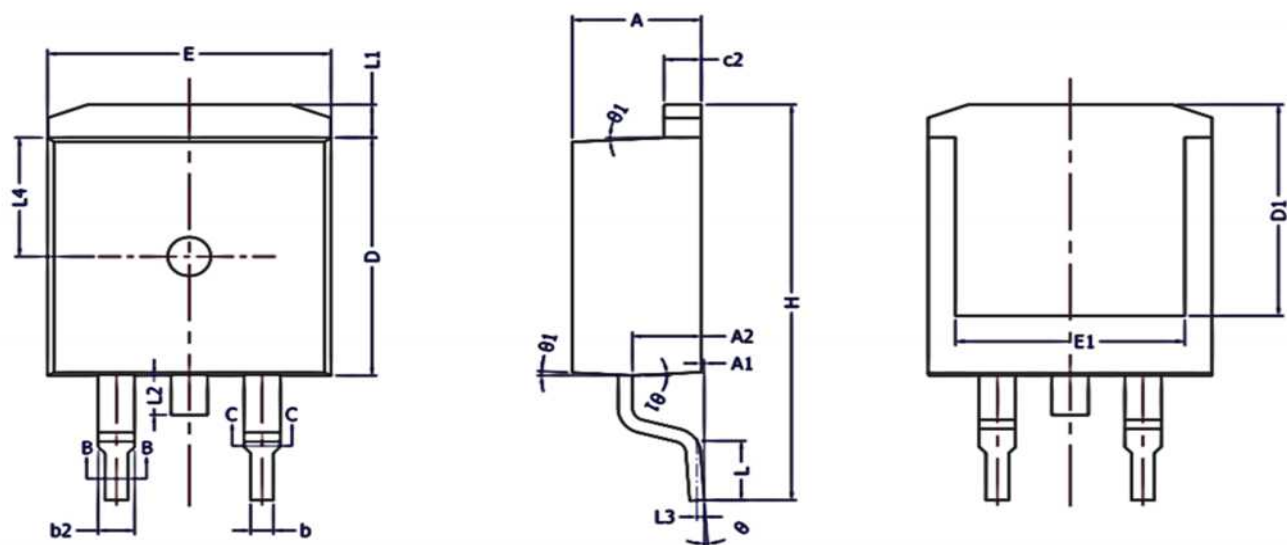


Fig. 19 FRD transient thermal impedance ($D=t_p/T$)

Package Information

TO-263-2L

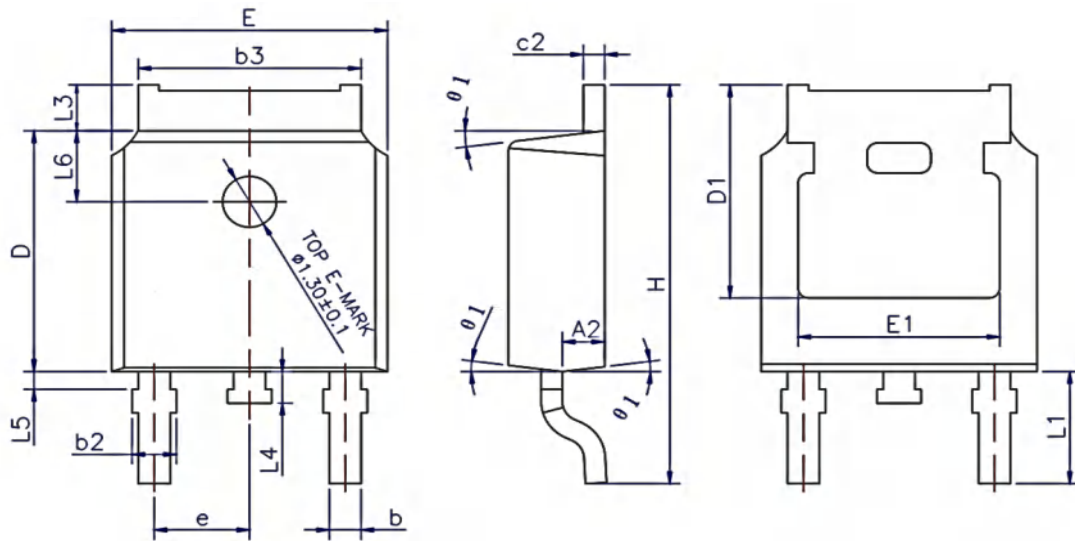

**COMMON DIMENSIONS
(UNITS OF MEASURE =MILLIMETER)**

SYMBOL	MIN	NOM	MAX
A	4.40	4.50	4.60
A1	0	0.10	0.25
A2	2.20	2.40	2.60
b	0.76	---	0.89
b1	0.75	0.80	0.85
b2	1.23	---	1.37
b3	1.22	1.27	1.32
c	0.47	---	0.60
c1	0.46	0.51	0.56
c2	1.25	1.30	1.35
D	9.10	9.20	9.30
D1	8.00	---	---
E	9.80	9.90	10.00
E1	7.80	---	---
e	2.54 BSC		
H	14.90	15.30	15.70
L	2.00	2.30	2.60
L1	1.17	1.27	1.40
L2	---	---	1.75
L3	0.25BSC		
L4	4.60 REF		
theta	0°	---	8°
theta1	1°	3°	5°

NOTES:
ALL DIMENSIONS REFER TO JEDEC STANDARD TO-263 AB
DO NOT INCLUDE MOLD FLASH OR PROTRUSIONS.

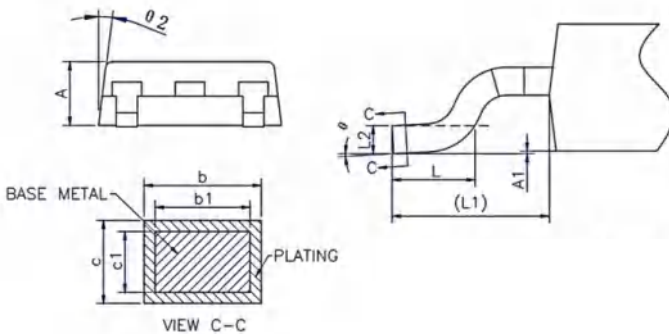
Package Information

TO-252-2L



COMMON DIMENSIONS
(UNITS OF MEASURE =MILLIMETER)

SYMBOL	MIN	NOM	MAX
A	2.20	2.30	2.38
A1	0	---	0.10
A2	0.90	1.01	1.10
b	0.72	---	0.85
b1	0.71	0.76	0.81
b2	0.72	---	0.90
b3	5.13	5.33	5.46
c	0.47	---	0.60
c1	0.46	0.51	0.56
c2	0.47	---	0.60
D	6.00	6.10	6.20
D1	5.25	---	---
E	6.50	6.60	6.70
E1	4.70	---	---
e	2.186	2.286	2.386
H	9.80	10.10	10.40
L	1.40	1.50	1.70
L1	2.90 REF		
L2	0.508 BSC		
L3	0.90	---	1.25
L4	0.60	0.80	1.00
L5	0.15	---	0.75
L6	1.80 REF		
θ	0°	---	8°
θ1	5°	7°	9°
θ2	5°	7°	9°



NOTES:
ALL DIMENSIONS REFER TO JEDEC STANDARD
TO-252 AA DO NOT INCLUDE MOLD FLASH OR
PROTRUSIONS

Revision History

Ver.	Date	Change Notice
1.0	2021/06/30	Released

